

UNITED STATES PATENT DOCUMENTS

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SJL	AA	6,420,503 B1	07/16/02	Jeyaraman et al.	526	257	
	AB	5,731,126	03/24/98	Takemura et al.	430	270.1	
	AC	5,240,813	08/31/93	Watanabe et al.	430	280	
	AD	5,691,396	11/25/97	Takemura et al.	522	82	
	AE	5,547,806	08/20/98	Watanabe	430	176	
	AF	6,342,562 B1	01/29/02	Kozawa et al.	524	588	
	AG	5,100,503	03/31/92	Altman et al.	158	643	
	AH	4,745,169	05/17/88	Supiyama et al.	528	43	
	AI	5,882,844	03/16/99	Tsuchiya et al.	430	288.1	
	AJ	6,087,064	07/11/00	Lin et al.	430	270.1	
	AK	8,210,858 B1	04/03/01	Lin et al.	430	270.1	
	AL	6,309,796 B1	10/30/01	Nakashima et al.	430	287.1	
	AM	6,420,084 B1	07/16/02	Angelopoulos et al.	430	270.1	
	AN	6,420,088 B1	07/16/02	Angelopoulos et al.	430	272.1	
	AO	3,969,543	07/13/78	Roberts et al.	427	54	
	AP	5,812,170	03/18/97	Takemura et al.	430	270.1	
	AQ	5,731,126	03/24/98	Takemura et al.	430	270.1	
✓	AR	5,972,560	10/26/99	Kaneko et al.	430	270.1	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
SJL	AS	WO 00/46267	08/10/00	WIPO	_____	_____	Yes
↓	AT	WO 02/091083 A1	11/14/02	WIPO	_____	_____	Yes

Examiner:

Sin J. Lee

Date:

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